Supplementary Information

Room Temperature Near Unity Spin Polarization in 2D Van der

Waals Heterostructures

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Supplementary Note 1. DFT calculations of PbI₂

Density-functional theory (DFT) calculations of PbI₂ were performed using Vienna ab initio Simulation Package (VASP)^{1, 2}. A slab was used to model the thin films of PbI₂. The exchange correlation functional is approximated by the generalized gradient approximation as parametrized by Perdew, Burke and Ernzerhof³, and pseudopotentials were constructed by the projector augmented wave method^{4, 5}. The Brillouin zone is sampled by a mesh of $12 \times 12 \times 8$ for the bulk and a mesh of $12 \times 12 \times 1$ for the thin films.

The band structure of the PbI₂ thin film with a thickness of 20 layers is shown in the main manuscript. We have also performed calculations for the bulk phase and the 4L-PbI₂. Supplementary figure 1 shows the geometric structures and the supplementary figure 2 shows the calculated band structures. The geometric structure Spin-orbit coupling (SOC) was included in our calculations. Our results indicate that both are direct gap semiconductors. For the bulk phase, the valance band minimum (VBM) and the conduction band minimum (CBM) are located at the A point. Our results are in good agreement with previous studies^{6, 7}. Supplementary figure 2 (c-f) show the orbital projected band structure for the two phases. Essentially, it reveals that for the bulk phase the VBM at A is mainly composed of I-*P*z orbitals, while the CBM is mainly contributed by p orbitals of Pb atoms. The situation is slightly different at Γ point from that at the A point in that the VBM is mainly contributed by the I-*Pz* orbital.



Supplementary figure 1. The geometric structure for (a) the bulk PbI_2 and (b) the 4L-PbI₂. The lattice constants are a = b = 4.56 Å for both the bulk phase and the thin film. The lattice constant along the c axis is 6.98 Å for the bulk phase. The thickness of the 4L-PbI₂ is about 24.63 Å, which together along with a vacuum region of 20 Å gives rise to 44.63 Å for the lattice constant along the c axis in our DFT calculations.



Supplementary figure 2. Band structure for (a) the bulk phase and (b) the 4L-PbI₂. (c)-(f) show the orbital-projected band structure for the two phases.

Supplementary Note 2. Numerical calculations for carrier diffusion and the corresponding degree of polarization

In order to quantitatively analyze the circularly polarized PL of PbI₂ layers in PbI₂/WS₂ heterostructure with different thicknesses, we built a numerical calculation model based on the population and distribution of carriers in PbI₂ layers, which can be described by a one-dimensional diffusion supplementary equation as following:

$$\frac{\partial n(x,t)}{\partial t} = D \frac{\partial^2 n(x,t)}{\partial x^2} - \eta n^2(x,t)$$
(1)

where n(x,t) is the carrier population at the depth of x nm of the PbI₂ layers with time delay t. The initial carrier distribution of the PbI₂ layers is given by $n(x,0) = n_0 \exp(-\alpha x)$ with absorption coefficient α being 4.09×10^5 cm⁻¹. The average value of the carrier diffusion coefficient D of PbI₂ is 0.039 cm²s⁻¹. The values of α and D are taken from the literature⁸. The bimolecular recombination coefficient η is obtained as 2.55×10^{-1} cm²s⁻¹ by fitting the decay curves of PbI₂ in PbI₂/WS₂ heterostructure with thickness larger than 200 nm in which the carrier injection to WS₂ can be neglected⁸. The carriers close to the bottom layer of PbI₂ were assumed to transfer to WS₂ layer instantly via type-I charge transfer, therefore the boundary condition is given as $n(X - X_{min}, t) = 0$. Here X is the thickness of the PbI₂ layers, and $X_{min} = 9$ nm is the minimum thickness of the PbI₂ layers, above which the time-resolved photoluminescence (TRPL) measurements can be conducted under laboratory conditions. τ_{eff} denotes the effective lifetime of the carriers in the PbI₂ layers, which is weighted averagely based on n(x,t) as

$$\tau_{eff}(X) = \frac{1}{N_0} \int_{t=0}^{t=t_d} \int_{x=0}^{x=X-X_{\min}} n(x,t) dx dt$$
(2)

where N_0 is the normalization constant. The PL circularly polarized degree P_{PL} can be described in its simplest form by the supplementary equation⁹

$$P(X) = \frac{P_0}{1 + \tau_{eff}(X) / \tau_s}$$
(3)

In our case $P_0 = 100\%$, τ_s is the carrier spin relaxation time. By solving supplementary equation 1, and substituting the result to supplementary equation 2 and

3, the circularly polarized PL of PbI₂/WS₂ heterostructure with different thicknesses is shown in Figure 2(c) in the main paper. The experiment data is also depicted in Figure 2(c) for comparison. Here time t_d =10 ps, τ_s =15 ps.

Supplementary Note 3. Schematic of the experimental set-up



Supplementary figure 3. Experimental setup for helicity-resolved micro-PL spectroscopy.

Supplementary Note 4. Optical characteristics of pure PbI₂

We synthesized pure PbI₂ samples on SiO₂/Si and mica substrates using the PVD method for comparison. Supplementary figure 4 (a) and (c) show the optical images of the grown PbI₂ on SiO₂/Si substrate and mica, respectively. Supplementary figure 4 (b), (d) show the corresponding atomic force microscopy (AFM) images, indicating PbI₂ thickness of 230 nm and 44.7 nm on SiO₂/Si substrate and mica substrate, respectively. Micro Raman spectroscopy was performed for further characterization of PbI₂ samples on different substrates (Supplementary figure 4 (e)). Three feature peaks associated with PbI₂ are identified: E_g peak located at 75 cm⁻¹, A_{1g} peak located at 95 cm⁻¹, and $E_u + A_{2u}$ peak located at 105 cm⁻¹. The observed peaks are consistent with those reported in the previous work¹⁰, and show no obvious changes on the SiO₂/Si and mica substrate.

In order to compare the effects of different substrates on the spin polarization of PbI₂, we measured the circularly polarized PL spectra of PbI₂ on the SiO₂/Si and mica substrate. We measured the circularly polarized PL spectra of PbI₂ under σ - polarized light laser excitation at 488 nm. The results are shown in supplementary figure 5 (a) and (b). The degree of polarization ρ of pure PbI₂ is only about 10%, and there is no significant difference between SiO₂/Si and mica substrates. In addition, we investigated the effect of different wavelengths of excitation light on the spin polarization of PbI₂ (Supplementary figure 5 (c, d)). The ρ of PbI₂ on different substrates is close to zero under continuous wave (CW) laser excitation at 405 nm due to the off-resonant excitation.



Supplementary figure 4. (a), (c) Optical images of PbI_2 on SiO_2/Si and Mica substrates, respectively. All scale bar:10 μ m. (b), (d) Corresponding AFM images of (a) and (c). (e) Raman spectra of PbI_2 on SiO_2/Si and Mica substrates, respectively. The excitation is a 532 nm CW laser.



Supplementary figure 5. Room-temperature circularly polarized PL spectra from PbI₂ on SiO₂/Si (a), (c) and Mica substrates (b), (d) under the excitation of 488 nm and 405 nm σ - polarization CW laser. For each situation, the degree of polarization ρ calculated from the corresponding polarization-resolved spectra is shown in the lower panel.

Supplementary Note 5. Optical characteristics of pure WS₂ atomic layers

For comparison, we synthesized WS₂ atomic layers on Si wafers with different thicknesses by changing the deposition temperature. We measured the circular polarization resolved PL spectra of the monolayer and bilayer WS₂ excited by σ -polarized light at room temperature. For the as-grown monolayer WS₂, the calculated ρ of the A-exciton PL emission is about 15% (Supplementary figure 6 (a)). For bilayer WS₂, we observe three PL emission peaks assigned to the B-exciton, A-exciton, and indirect band transition and the calculated degree of polarization ρ are about 40%, 12%, and 0%, respectively (Supplementary figure 6 (b)). These observations are consistent with the previous studies^{11,12}.



Supplementary figure 6. Circularly polarized PL spectra from monolayer (a) and bilayer (b) WS₂, and the corresponding degree of polarization ρ calculated from PL spectra from WS₂. The insets are the optical images. All scale bar: 10 μ m. The excitation is 488 nm σ - polarization CW laser at room temperature.

Supplementary Note 6. Thickness dependent TRPL spectra of pure PbI₂

We measured the time-dependent spectra of pure PbI_2 with different thicknesses. Supplementary figure 7 shows the normalized TRPL of PbI_2 with typical thicknesses of 13.2 nm, 31.5 nm and the bulk. We found similar TRPL curves with a fast decay time of about 45 ps, indicating that the intrinsic recombination process of PbI_2 is basically the same within the range of thickness in this study.



Supplementary figure 7. TRPL data from pure PbI_2 with different thicknesses at room temperature. The excitation light source is 440 nm femtosecond laser.

Supplementary Note 7. Excitation power dependent degree of polarization

We measured the degree of polarization of PbI₂ in PbI₂/WS₂ heterostructures at different excitation powers. Increasing the power of the σ - polarized excitation from 2 μ W to 10 μ W, we observe the initial very weak σ + polarized PL emission increases (Supplementary figure 8), indicating a decreasing degree of polarization at higher excitation power. Supplementary figure 8 (b) shows the calculated degree of polarization from sequence excitation powers. The slightly reduced degree of polarization from 0.999 to 0.913 can be understood by the decreased spin polarization lifetime due to a higher chance of carrier spin flip with a higher density of carrier at high excitation powers. Similar results have been observed in different systems, such as GaAs nanostructures¹³.



Supplementary figure 8. (a) Typical power-dependent circularly polarized PL spectra from PbI₂ in PbI₂/WS₂ heterostructures at room temperature. (b) Degree of polarization ρ of PbI₂ as a function of excitation power.

Supplementary Note 8. Excitation wavelength dependent degree of polarization

We measured the circular polarization of the heterostructures under 400 nm femtosecond pulsed laser excitation which is further away from the resonance excitation conditions compared with the 441 nm excitation shown in the main text. Supplementary figure 9 shows the circularly polarized PbI₂ PL spectra and their dynamics in layered PbI₂/monolayer-WS₂ (a, b) and PbI₂/monolayer-WSe₂ (c, d) heterostructures. For both cases, we observed that the σ - and σ + polarized PL signals were similar, showing no observable polarization. The time-resolved σ - and σ + polarized PL spectra of PbI₂ from the heterostructures shows about 22 ps (supplementary figure 9 (b)) and 26 ps (Supplementary figure 9 (d)) in PbI₂/monolayer-WS₂ and PbI₂/monolayer-WSe₂ heterostructures, respectively.

We summarized the ρ of layered PbI₂/monolayer-WS₂ heterostructures at different excitation wavelengths in supplementary figure 10, showing ρ being about 0.998, 0.358, and 0.091 under the excitation of 488 nm, 441 nm, and 400 nm lasers, respectively.



Supplementary figure 9. Room-temperature circularly polarized PL spectra (a, c) and the corresponding TRPL data (b, d) from PbI_2/WS_2 and PbI_2/WS_2 heterostructures. The PL spectra taken from the streak camera image. The excitation light source is 400 nm σ - polarization femtosecond laser with a power of 24 μ W.



Supplementary figure 10. Degree of polarization ρ of PbI₂ in PbI₂/WS₂ heterostructure as a function of excitation wavelength.

Supplementary Note 9. Polarization dynamics of pure PbI₂

We measured the temperature-dependent and time-resolved circularly polarized PL of pure PbI₂ samples under the excitation of σ - polarized 100-fs laser at 440 nm. Supplementary figure 11 shows the temperature-dependent circularly polarized TRPL (a-d)) from pure PbI₂ at typical temperatures and the corresponding degree of polarization ρ (e-f)) as a function of time.



Supplementary figure 11. (a)-(d) Circularly polarized TRPL data from pure PbI₂ at typical temperatures. (e)-(f) Corresponding degree of polarization ρ as a function of time calculated from the TRPL spectra. Excitation: 440 nm σ - polarization femtosecond laser pulses.

Supplementary Note 10. Thickness dependent polarization of PbI₂ in PbI₂/WSe₂ heterostructures.

We prepared PbI₂/WSe₂ heterostructures with different thicknesses for circular polarization measurement. The ρ of PbI₂ decreased with increasing thickness due to the increase of carrier lifetime, which is similar to PbI₂/WS₂ heterostructures. Supplementary figure 12 shows the calculated PbI₂ the ρ in heterostructures with different thicknesses. When the thickness of PbI₂ in the heterostructure increases from 9.5 nm to 30.9 nm, the ρ decreases from 0.998 to 0.758.



Supplementary figure 12. Degree of polarization ρ of PbI₂ as a function of thickness of the PbI₂/WSe₂ heterostructures. Excitation: 488 nm σ - polarization CW laser at room temperature.

Supplementary Note 11. Temperature dependent circularly polarized PL spectra of PbI₂/WSe₂ heterostructures.

Supplementary figure 13 shows the circularly polarized PL spectrum from a PbI_2/WSe_2 heterostructure at typical temperatures. We find that the ρ of PbI_2 PL in heterostructures decreases from 83.2% to 66.6% when the temperature decreases from 227 K to 77 K. As temperature decrease, interlayer charge transfer decreases, and the polarization decreases accordingly.



Supplementary figure 13. Circularly polarized PL spectra of PbI₂/WSe₂ heterostructure at different temperatures under the excitation of a 488 nm σ - polarized CW laser beam.

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